

# OptiMOS<sup>™</sup>- 6 Power-Transistor





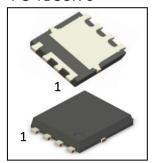
## **Product Summary**

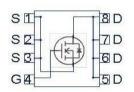
$V_{\mathrm{DS}}$	40	٧
$R_{\mathrm{DS(on),max}}$	1.3	mΩ
I <sub>D</sub>	120	Α

#### **Features**

- OptiMOS™ power MOSFET for automotive applications
- N-channel Enhancement mode Normal Level
- AEC Q101 qualified
- MSL1 up to 260°C peak reflow
- 175°C operating temperature
- Green Product (RoHS compliant)
- 100% Avalanche tested

#### PG-TDSON-8





Туре	Package	Marking
IAUC120N04S6N013	PG-TDSON-8	6N04N013

## **Maximum ratings,** at $T_j$ =25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current <sup>1)</sup>	ID	T <sub>C</sub> =25°C, V <sub>GS</sub> =10V	120	А
		$T_{\rm C}$ =25°C, $V_{\rm GS}$ =10 $V^{2,3)}$	150	
		$T_{\rm C}$ =100°C, $V_{\rm GS}$ =10 $V^{2)}$	120	
Pulsed drain current <sup>2)</sup>	I <sub>D,pulse</sub>	T <sub>C</sub> =25°C	480	1
Avalanche energy, single pulse <sup>2)</sup>	E <sub>AS</sub>	$I_{\rm D}$ =60A, $R_{\rm G,min}$ =25 $\Omega$	184	mJ
Avalanche current, single pulse	IAS	$R_{\rm G,min}$ =25 $\Omega$	60	А
Gate source voltage	V <sub>GS</sub>	-	±20	V
Power dissipation	P <sub>tot</sub>	T <sub>C</sub> =25°C	115	W
Operating and storage temperature	$T_{\rm j},T_{\rm stg}$	-	-55 <b>+</b> 175	°C



Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Thermal characteristics <sup>2)</sup>						
Thermal resistance, junction - case	$R_{\mathrm{thJC}}$	-	-	-	1.3	K/W
Thermal resistance, junction - ambient	$R_{\mathrm{thJA}}$	6 cm <sup>2</sup> cooling area <sup>4)</sup>	-	-	50	

## **Electrical characteristics,** at $T_j$ =25 °C, unless otherwise specified

#### Static characteristics

Drain-source breakdown voltage	$V_{(BR)DSS}$	$V_{GS}$ =0V, $I_D$ = 1mA	40	ı	-	V
Gate threshold voltage	$V_{\rm GS(th)}$	$V_{\rm DS}=V_{\rm GS}, I_{\rm D}=60\mu{\rm A}$	2.2	2.6	3.0	
Zero gate voltage drain current	I <sub>DSS</sub>	$V_{\rm DS}$ =40V, $V_{\rm GS}$ =0V, $T_{\rm j}$ =25°C	-	1	1	μA
		$V_{\rm DS}$ =40V, $V_{\rm GS}$ =0V, $T_{\rm j}$ =125°C <sup>2)</sup>	-	-	15	
Gate-source leakage current	I <sub>GSS</sub>	V <sub>GS</sub> =20V, V <sub>DS</sub> =0V	-	-	100	nA
Drain-source on-state resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> =7V, I <sub>D</sub> =60A	-	1.21	1.90	mΩ
		V <sub>GS</sub> =10V, I <sub>D</sub> =60A	-	1.02	1.34	



Parameter	Symbol Conditions		Values			Unit
			min.	typ.	max.	
Dynamic characteristics <sup>2)</sup>						
Input capacitance	Ciss		-	3277	4260	pF
Output capacitance	Coss	V <sub>GS</sub> =0V, V <sub>DS</sub> =25V, f=1MHz	-	1001	1301	]
Reverse transfer capacitance	C <sub>rss</sub>		-	44	66	
Turn-on delay time	$t_{d(on)}$		-	6	-	ns
Rise time	t <sub>r</sub>	V <sub>DD</sub> =20V, V <sub>GS</sub> =10V,	-	3	-	
Turn-off delay time	$t_{d(off)}$	$I_{\rm D}$ =120A, $R_{\rm G}$ =3.5 $\Omega$	-	13	-	
Fall time	$t_{f}$		-	7	-	
Gate Charge Characteristics <sup>2)</sup>		<b>,</b>				
Gate to source charge	Q <sub>gs</sub>		-	14	19	nC
Gate to drain charge	Q <sub>gd</sub>	$V_{\rm DD}$ =32V, $I_{\rm D}$ =120A, $V_{\rm GS}$ =0 to 10V	-	10	15	
Gate charge total	Qg		-	51	68	
Gate plateau voltage	$V_{ m plateau}$		-	4.3	-	V
Reverse Diode						
Diode continous forward current <sup>2)</sup>	Is	T -25°C	-	-	120	А
Diode pulse current <sup>2)</sup>	I <sub>S,pulse</sub>	− <i>T</i> <sub>C</sub> =25°C	-	-	480	
Diode forward voltage	V <sub>SD</sub>	V <sub>GS</sub> =0V, I <sub>F</sub> =60A, T <sub>j</sub> =25°C	-	0.8	1.1	V
Reverse recovery time <sup>2)</sup>	t <sub>rr</sub>	$V_R$ =20V, $I_F$ =50A, $di_F/dt$ =50A/ $\mu$ s	-	49	-	ns
Reverse recovery charge <sup>2)</sup>	Q <sub>rr</sub>		-	49	-	nC

 $<sup>^{1)}</sup>$  Current is limited by package; with an  $R_{\rm thJC}$  = 1.3K/W the chip is able to carry 218 A at 25°C.

<sup>&</sup>lt;sup>2)</sup> The parameter is not subject to production test- verified by design/characterization.

 $<sup>^{3)}</sup>$  The product can operate at a current of I<sub>D</sub>=150A for a limited period of time up to t=100h at T<sub>c</sub>=25  $^{\circ}$ C

 $<sup>^{4)}</sup>$  Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm $^2$  (one layer, 70  $\mu$ m thick) copper area for drain connection. PCB is vertical in still air.

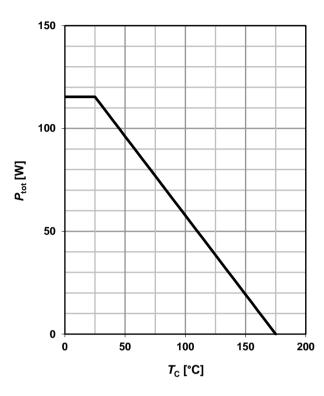


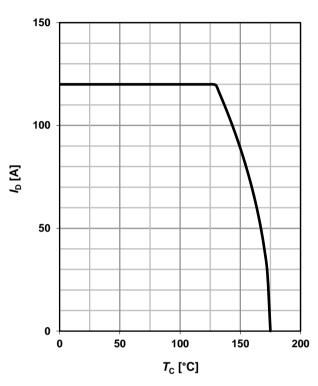
#### 1 Power dissipation

$$P_{\text{tot}} = f(T_{\text{C}}); V_{\text{GS}} = 10 \text{ V}$$

## 2 Drain current

$$I_{\rm D} = f(T_{\rm C}); \ V_{\rm GS} = 10 \ {\rm V}$$





## 3 Safe operating area

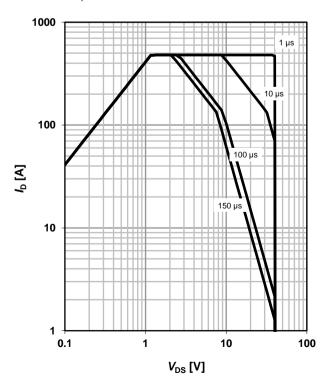
$$I_D = f(V_{DS}); T_C = 25 \text{ °C}; D = 0$$

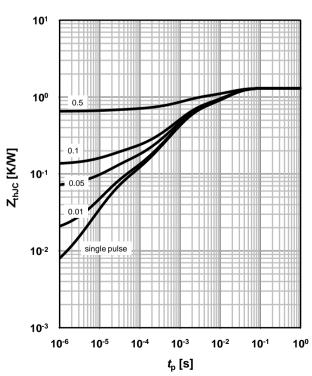
parameter:  $t_p$ 

#### 4 Max. transient thermal impedance

$$Z_{\text{thJC}} = f(t_{p})$$

parameter:  $D=t_p/T$ 



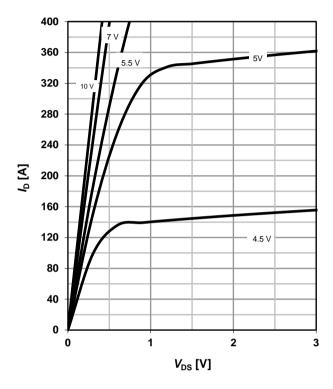




## 5 Typ. output characteristics

 $I_{\rm D} = f(V_{\rm DS}); T_{\rm j} = 25 \,{}^{\circ}{\rm C}$ 

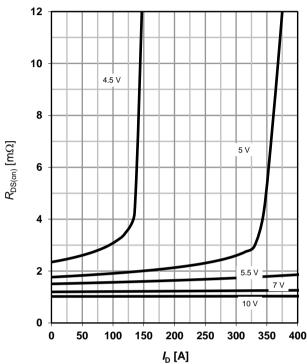
parameter: V<sub>GS</sub>



#### 6 Typ. drain-source on-state resistance

 $R_{DS(on)} = f(I_D); T_j = 25 \text{ °C}$ 

parameter: V<sub>GS</sub>



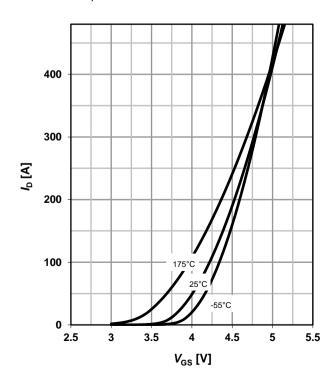
#### 7 Typ. transfer characteristics

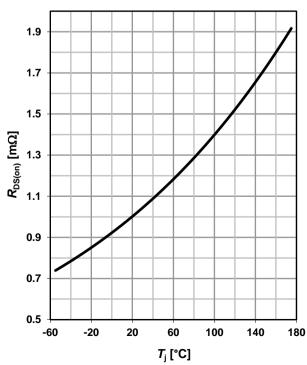
 $I_D = f(V_{GS}); V_{DS} = 6V$ 

parameter: T<sub>i</sub>

## 8 Typ. drain-source on-state resistance

$$R_{DS(on)} = f(T_j); I_D = 60 \text{ A}; V_{GS} = 10 \text{ V}$$







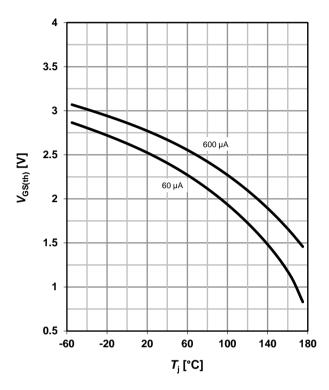
## 9 Typ. gate threshold voltage

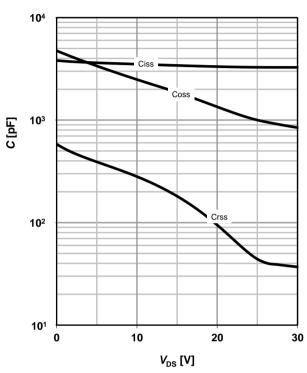
 $V_{GS(th)} = f(T_i); V_{GS} = V_{DS}$ 

parameter: I<sub>D</sub>

## 10 Typ. capacitances

 $C = f(V_{DS}); V_{GS} = 0 V; f = 1 MHz$ 





## 11 Typical forward diode characteristicis

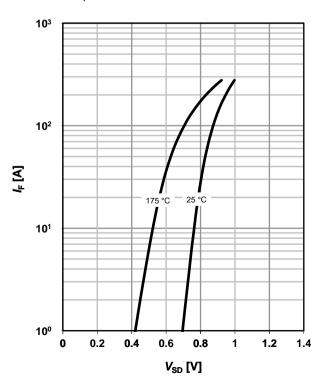
 $IF = f(V_{SD})$ 

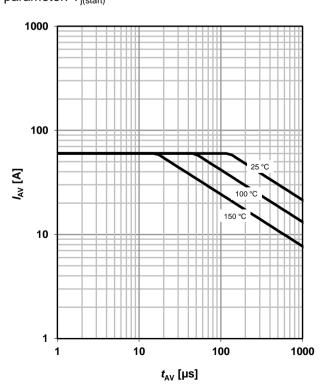
parameter:  $T_{\rm j}$ 

#### 12 Avalanche characteristics

 $I_{AS} = f(t_{AV})$ 

parameter: T<sub>j(start)</sub>





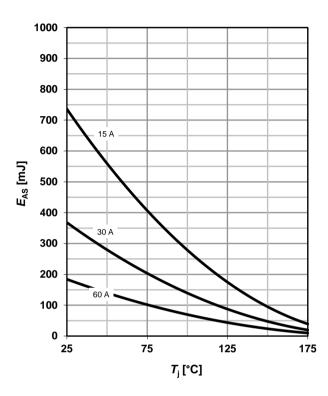


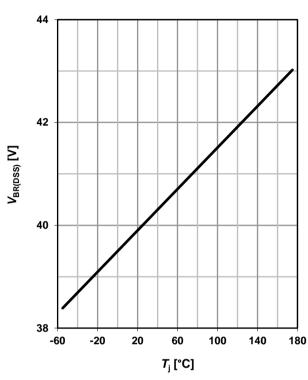
#### 13 Avalanche energy

## $E_{AS} = f(T_i)$

#### 14 Drain-source breakdown voltage

$$V_{BR(DSS)} = f(T_i); I_D = 1 \text{ mA}$$

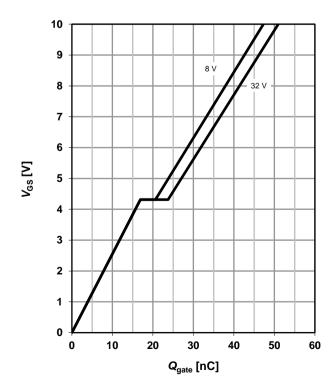




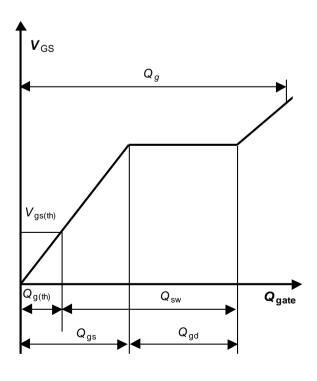
## 15 Typ. gate charge

 $V_{GS} = f(Q_{gate}); I_D = 120 A pulsed$ 

parameter: V<sub>DD</sub>



#### 16 Gate charge waveforms





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**Revision History** 

Version	Date	Changes